Se	arcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	•	
10/626,552	YAMAI ET AL.		
Examiner	Art Unit		
lamaifar A. Lavina	1764		

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
422/159,2	25,228,232	7/8/2007	JAL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
updated inventor search.	7/8/2007	
updated search, text only, see attached EAST search history.	7/8/2007	JAL
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